

Notice of References Cited	Application/Control No. 10/664,379		Applicant(s)/Patent Under Reexamination BENZER ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,466,054	10-2002	Kameyama et al.	326/68
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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